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## N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET 100 V, 5.5 A, 104 m $\Omega$

### **Features**

- Shielded Gate MOSFET Technology
- Max  $r_{DS(on)}$  = 104 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 4.2 A
- Max  $r_{DS(on)}$  = 156 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 3.4 A
- HBM ESD protection level > 6 kV typical (Note 4)
- High performance trench technology for extremely low rDS(on)
- High power and current handling capability in a widely used surface mount package
- 100% UIL Tested
- RoHS Compliant

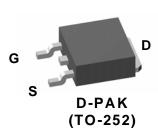


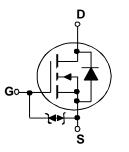
### General Description

This N-Channel logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance. G-S zener has been added to enhance ESD voltage level.

### Application

■ DC-DC conversion





### MOSFET Maximum Ratings T<sub>C</sub> = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			100	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T <sub>C</sub> = 25 °C		5.5		
I <sub>D</sub>	-Continuous	TA = 25 °C	(Note 1a)	4.2	Α	
	-Pulsed			15		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	12	mJ	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25 °C		29		
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	3.1		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C	

### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	4.3	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	96	C/vv

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD86113LZ	FDD86113LZ	D-PAK(TO-252)	13 "	16 mm	2500 units

# FDD86113LZ N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET

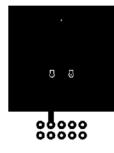
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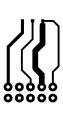
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	cteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	100	1		V	
$\Delta BV_{DSS}$ $\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , referenced to 25 °C		72		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V			1	μA	
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μA	
On Chara	cteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250 \ \mu A$	1	1.5	3	V	
$\Delta V_{GS(th)}$ $\Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-5		mV/°C	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.2 A		87	104	mΩ	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 3.4 A		116	156		
		$V_{GS} = 10 \text{ V}, I_{D} = 4.2 \text{ A}, T_{J} = 125 \text{ °C}$		142	170		
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, \ \text{I}_{D} = 4.2 \text{ A}$		9		S	
Dynamic	Characteristics						
C <sub>iss</sub>	Input Capacitance			213	285	pF	
C <sub>oss</sub>	Output Capacitance	─ V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1MHz		55	75	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			2.4	5	pF	
R <sub>g</sub>	Gate Resistance			1.4		Ω	
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time			3.6	10	ns	
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 50 V, I <sub>D</sub> = 4.2 A,		1.3	10	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		9.7	20	ns	
t <sub>f</sub>	Fall Time			1.6	10	ns	
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V		3.7	6	nC	
Q <sub>g(TOT)</sub>	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V V_{DD} = 50 V,$		1.9	3		
Q <sub>gs</sub>	Gate to Source Charge	$I_{\rm D} = 4.2 \rm{A}$		0.6		nC	
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			0.7		nC	
Drain-Sou	urce Diode Characteristics						
V <sub>SD</sub> S	Source to Drain Diade. Forward Valters	$V_{GS} = 0 V, I_{S} = 4.2 A$ (Note 2)		0.88	1.3	v	
	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 1.7 A$ (Note 2)		0.80	1.2	v	
t <sub>rr</sub>	Reverse Recovery Time	- I <sub>F</sub> = 4.2 A, di/dt = 100 A/μs		31	49	ns	
Q <sub>rr</sub>	Reverse Recovery Charge	$F = 4.2 \text{ A}, \text{ u/ul} = 100 \text{ A/}\mu\text{S}$		20	33	nC	

NOTES:

1. R<sub>0,1</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0,1C</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.

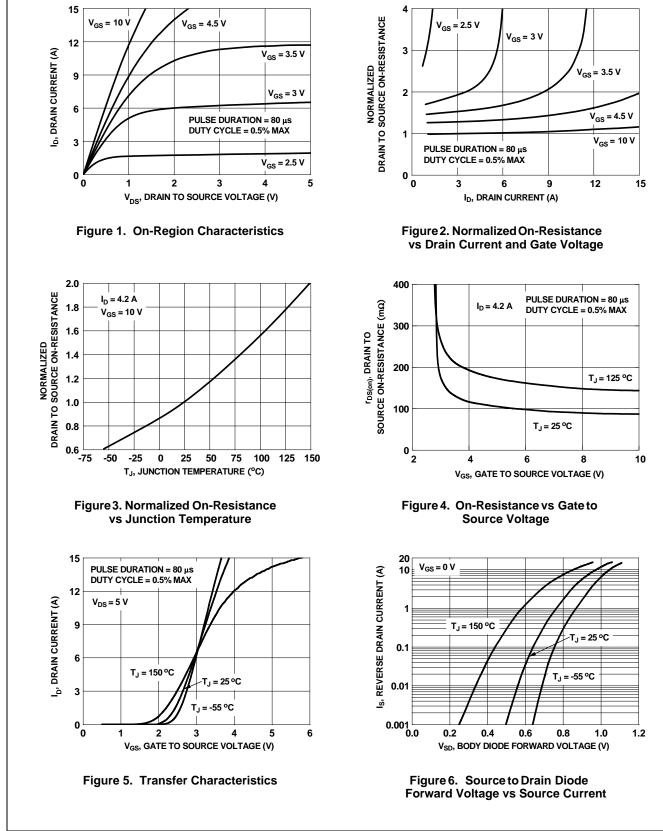


a) 40 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

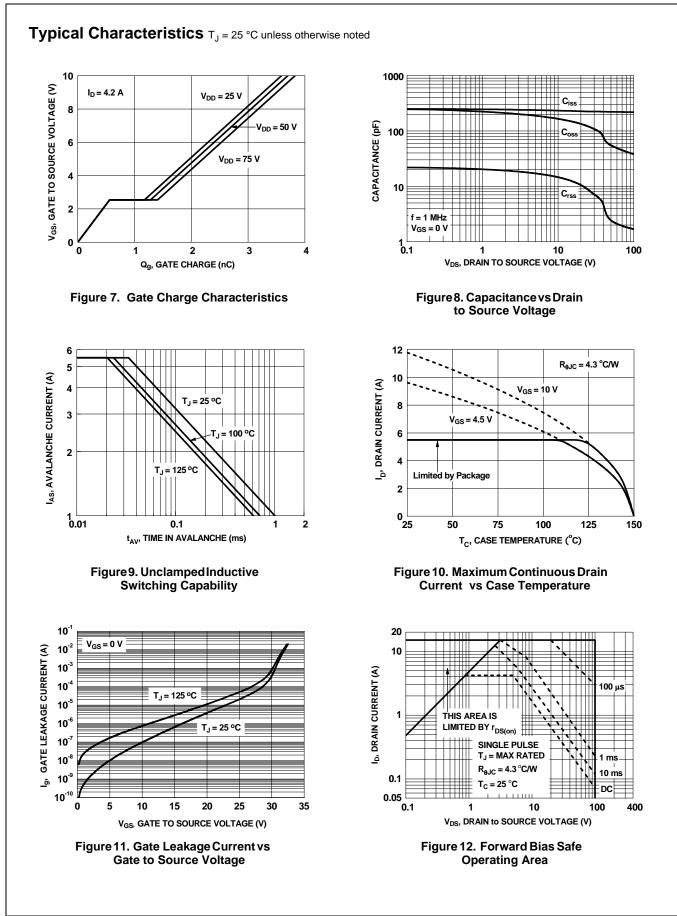


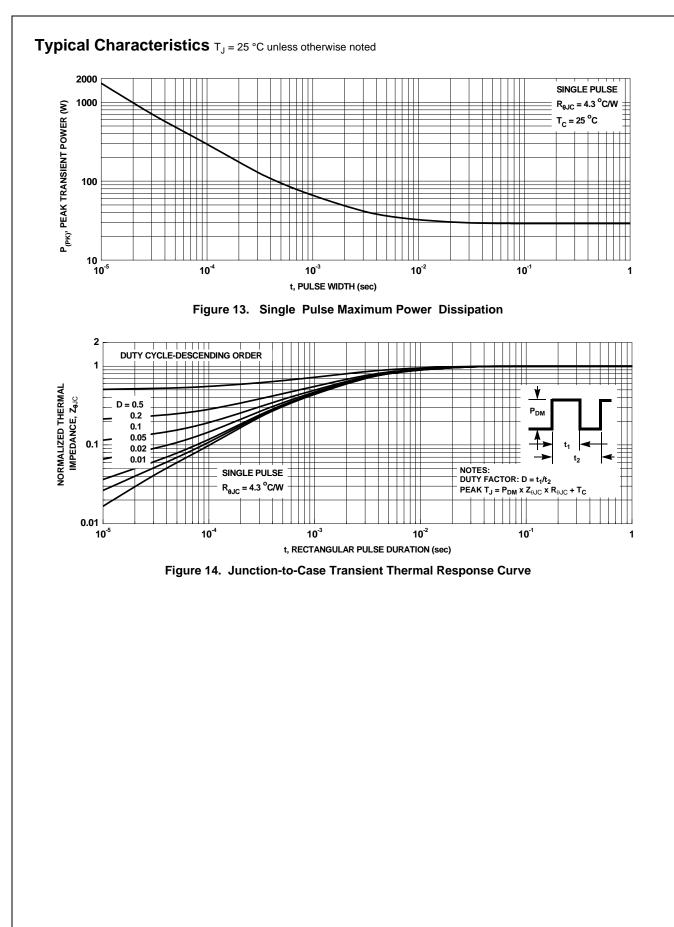
b) 96 °C/W when mounted on a minimum pad of 2 oz copper

Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.</li>
Starting T<sub>J</sub> = 25 °C, L = 1 mH, I<sub>AS</sub> = 5 A, V<sub>DD</sub> = 90 V, V<sub>GS</sub> = 10 V.
The diode connected between gate and source serves only as protection against ESD. No gate overvoltage rating is implied.



### Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted





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